

<b>Notice of References Cited</b>	Application/Control No. 10/003,920	Applicant(s)/Patent Under Reexamination KAWAHARA, HIDEYA	
	Examiner Li B. Zhen	Art Unit 2194	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,587,888 B1	07-2003	Chieu et al.	719/313
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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